



DESCRIPTION

The AM4430 is available in SOP8 Package.

BVDSS	RDSON	ID
30V	4.5mΩ	25A

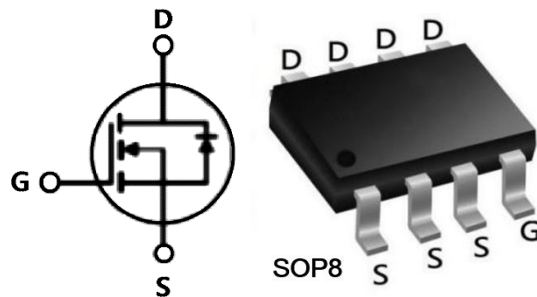
FEATURE

- $R_{DS(ON), typ.} = 4.5m\Omega @ V_{GS}=10V$
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Advanced high cell density Trench technology

ORDERING INFORMATION

Package Type	Part Number	
SOP8 SPQ:3,000pcs /Reel	M8	AM4430M8R
		AM4430M8VR
Note	V: Halogen free Package R: Tape & Reel	
AiT provides all RoHS products		

PIN DESCRIPTION



Pin#	Symbol	Function
1	S	Source
2	S	Source
3	S	Source
4	G	Gate
5	D	Drain
6	D	Drain
7	D	Drain
8	D	Drain



ABSOLUTE MAXIMUM RATINGS

T_A = 25°C, unless otherwise specified.

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V _{DS}	30	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current, V _{GS} @ 10V ⁽¹⁾ T _A =25°C	I _D	25	A
Continuous Drain Current, V _{GS} @ 10V ⁽¹⁾ T _A =70°C		15	
Pulsed Drain Current ⁽²⁾	I _{DM}	80	A
Single Pulse Avalanche Energy ⁽³⁾	E _{AS}	105.8	mJ
Avalanche Current	I _{AS}	51	A
Total Power Dissipation ⁽⁴⁾ T _A =25°C	P _D	10	W
Storage Temperature Range	T _{STG}	-55 to 150	°C
Operating Junction Temperature Range	T _J	150	°C
THERMAL RESISTANCE			
Thermal Resistance, Junction-Case ⁽¹⁾	R _{θJC}	35	°C/W
Thermal Resistance, Junction-Ambient ⁽¹⁾	R _{θJA}	85	

Stresses above may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated in the Electrical Characteristics are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

- (1) Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 0.5%
- (2) Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
- (3) E_{AS} condition: T_A=25°C, V_{GS}=15V, R_G=25Ω, L=0.5mH, I_{AS}=20A
- (4) The power dissipation is limited by 150°C junction temperature



ELECTRICAL CHARACTERISTICS

T_A = 25°C, unless otherwise specified.

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} =0V, I _D =250μA	30	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =30V, V _{GS} =0V,	-	-	1.0	μA
Gate to Body Leakage Current	I _{GSS}	V _{DS} =0V, V _{GS} =±20V	-	-	±100	nA
ON CHARACTERISTICS						
Static Drain-Source on-Resistance *	R _{DS(ON)}	V _{GS} =10V, I _D =20A		4.6	6	mΩ
		V _{GS} =4.5V, I _D =10A		6.1	8.6	
Gate Threshold Voltage	V _{GS(TH)}	V _{DS} =V _{GS} , I _D =250μA	1.0	1.5	2.5	V
DYNAMIC CHARACTERISTICS						
Input Capacitance	C _{iss}	V _{DS} =15V, V _{GS} =0V, f=1.0MHz	-	1700	-	pF
Output Capacitance	C _{oss}		-	320	-	
Reverse Transfer Capacitance	C _{rss}		-	300	-	
Total Gate Charge	Q _g	V _{DS} =15V, I _D =10A, V _{GS} =10V	-	45	-	nC
Gate-Source charge	Q _{gs}		-	3	-	
Gate-Drain charge	Q _{gd}		-	15	-	
SWITCHING CHARACTERISTICS						
Turn-on Delay Time	t _{d(ON)}	V _{DS} =15V, I _D =20A, R _{GEN} =3Ω, V _{GS} =10V	-	21	-	nS
Turn-on Rise Time	t _r		-	32	-	
Turn-off Delay Time	t _{d(OFF)}		-	59	-	
Turn-off Fall Time	t _f		-	34	-	
SOURCE-DRAIN DIODE CHARACTERISTICS						
Maximum Continuous Drain to Source Diode Forward Current	I _S		-	-	20	A
Maximum Pulsed Drain to Source Diode Forward Current	I _{SM}		-	-	80	A
Drain to Source Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _S =20A	-	-	1.2	V
Body Diode Reverse Recovery Time	t _{rr}	I _F =20A,	-	15	-	ns
Body Diode Reverse Recovery Charge	Q _{rr}	di/dt=100A/μs	-	4	-	nC

* Pulse Test: Pulse Width≤300μs, Duty Cycle≤0.5%



TYPICAL PERFORMANCE CHARACTERISTICS

Fig.1 Output Characteristics

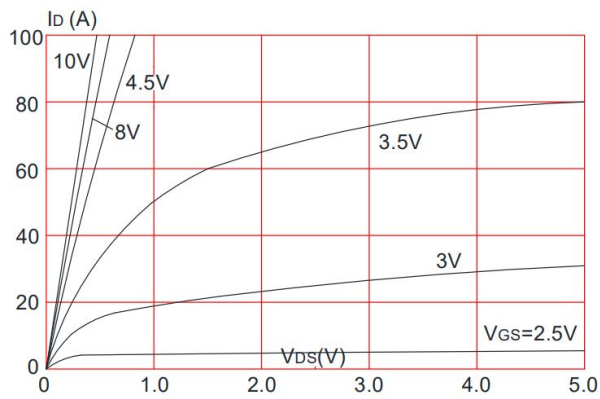


Fig.2 Typical Transfer Characteristics

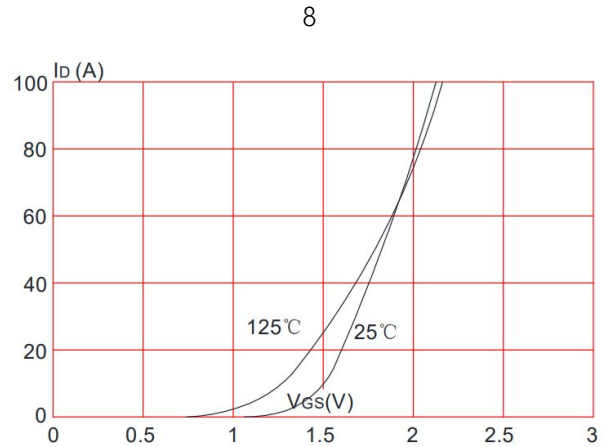


Fig.3 On-resistance vs. Drain Current

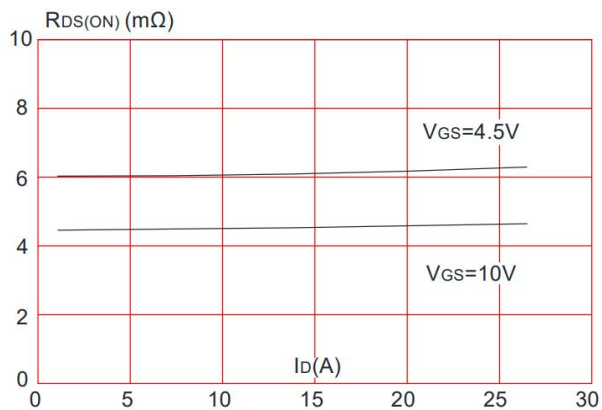


Fig.4 Body Diode Characteristics

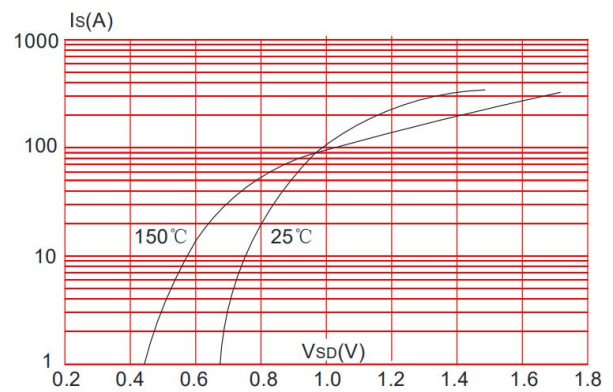


Fig.5 Gate Charge Characteristics

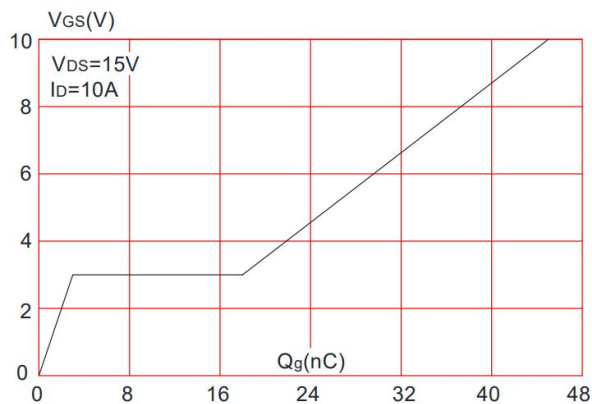


Fig.6 Capacitance Characteristics

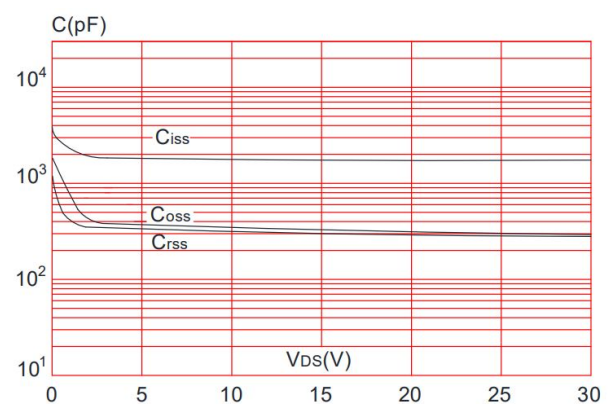




Fig.7 Normalized Breakdown Voltage vs. Junction Temperature

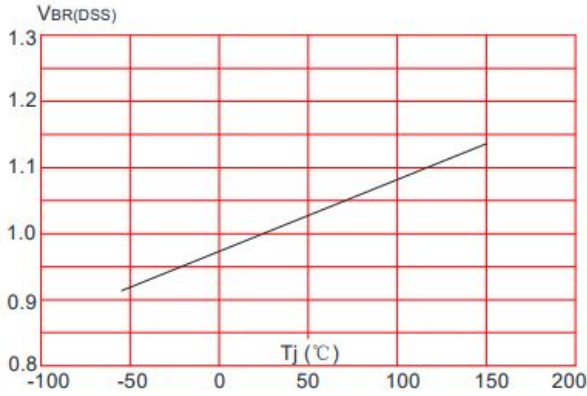


Fig.8 Normalized on Resistance vs. Junction Temperature

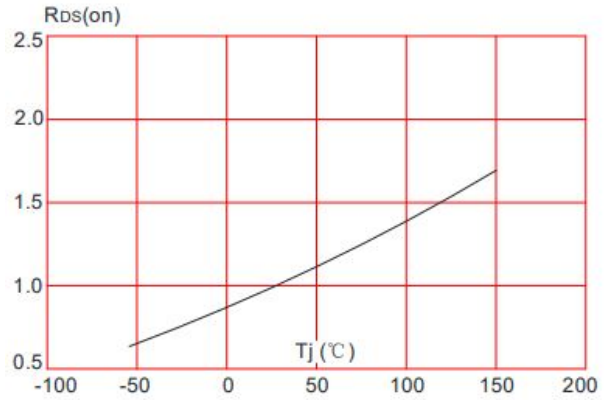


Fig.9 Maximum Safe Operating Area

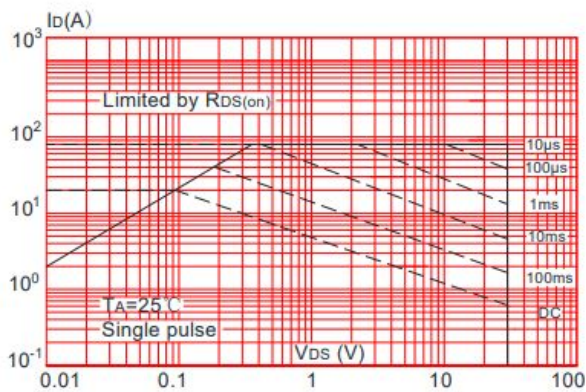


Fig.10 Maximum Continuous Drain Current vs. Ambient Temperature

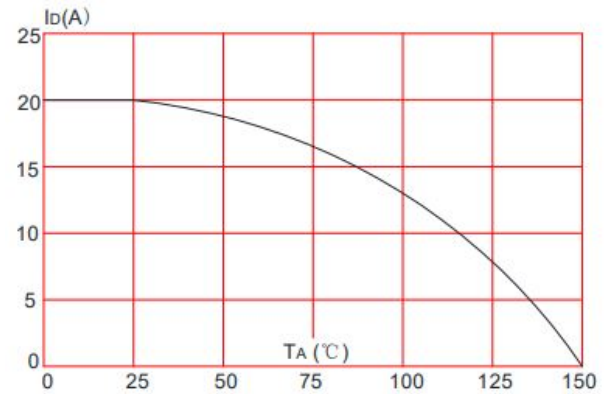
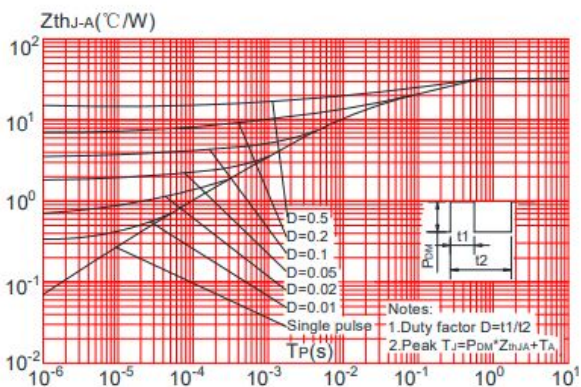


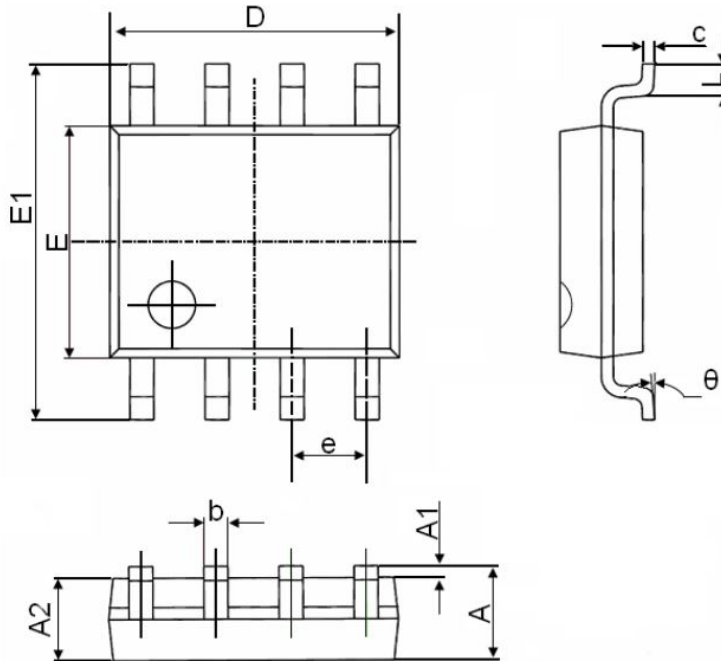
Fig.11 Maximum Effective Transient Thermal Impedance, Junction-to-Ambient





PACKAGE INFORMATION

Dimension in SOP8 (Unit: mm)



Symbol	Min.	Max.
A	1.350	1.750
A1	0.100	0.250
A2	1.350	1.550
b	0.330	0.510
c	0.170	0.250
D	4.700	5.100
E	3.800	4.000
E1	5.800	6.200
e	1.270 (BSC)	
L	0.400	1.270
θ	0°	8°



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